

多腔體物理氣相沉積系統 PVD

儀器詳細資訊

服務項目：離子束沉積、一般濺鍍、輔助濺鍍

申請服務辦法：一般服務/特殊服務/樣品準備須知

儀器開放時間：預計 2026 年 2 月底開放

預期回件時間：1~2 周，依據案件排序決定

基本參考資料：

Ion beam sputter deposition (IBSD) module, 200mm Φ wafer and 4inch $\square$ x 0.25in thick substrate stage

1. Primary Pumping Dry, $> 50\text{m}^3/\text{hr}$
2. High Vacuum pumping Mag Lev Turbomolecular, $> 2000\text{ l/s}$ & cryopump, pumping speed $\geq 1200\text{ l/s}$
3. Primary Sputter Ion Source RFICP, Gridded, 100-1500 eV, 300 mA (800 mA) Ar, Focused
4. Secondary In-situ clean, assist, etch ion source RFICP, Gridded, 50-1500 eV, 800 mA Ar, Defocused
5. Gases Ar, O₂, N₂
6. Target Carousel 4 x 6" Φ
7. Substrate Stage Vacuum chuck, rotation, tilt, 5-40°C temp control, shutter
8. Pressure: ultimate/base, pumpdown $\leq 2 \times 10^{-8}$ Torr, 1×10^{-6} Torr in $\leq 1\text{hr}$
9. Deposition: rate, non-uniformity 0.1 to 3 Å/sec Si, $\leq 1\text{-}5\%$
10. Etch: rate, non-uniformity 0.1 to 3 Å/sec Si, $\leq 5\%$

Magnetron sputter deposition (MSC) module, 200mm Φ wafer and 4 inch $\square$ x 0.25in thick substrate stage

1. Primary Pumping Dry, $> 50\text{m}^3/\text{hr}$ Dry,
2. High Vacuum pumping Mag Lev Turbomolecular, $> 2000\text{l/s}$, gate valve & cryopump, pumping speed $\geq 1200\text{ l/s}$
3. Sputter Cathodes, qty=6 Low pressure, $\geq 4\text{ in } \Phi$ target, $\geq 500\text{W}$ DC

4. Gases Ar, O₂, N₂
5. Substrate Stage, rotation, RT-450°C temp control, shutter
6. Pressure: ultimate/base, pumpdown $\leq 2 \times 10^{-8}$ Torr, 1×10^{-6} Torr in ≤ 1 hr
7. Deposition: rate, non-uniformity 0.1 to 3 Å/sec doped Si, $\leq 1\%$